

<b>Notice of References Cited</b>	Application/Control No. 10/822,993	Applicant(s)/Patent Under Reexamination WATANABE ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2003-168857	06-2003	JP	Seiko Instruments Inc	-----
	O					
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**NON-PATENT DOCUMENTS**

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*Thomas Parsons* 4/10/2006